

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	264	(quality adj2 metric) near10 (determ\$5 or estimat\$5)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L2	52	(quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:23
L3	3	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) same (interval)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:47
L4	1	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) same (decod\$3)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:48
L5	20	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and decod\$3	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:48
L6	6	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and decod\$3 and (criterion or criteria)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:49
L7	17	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and (criterion or criteria)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L8	31	((quality adj2 metric) near10 (determ\$5 or estimat\$5)) same threshold) and (criterion or criteria)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L9	17	((quality adj2 metric) near10 (determ\$5 or estimat\$5)) same threshold) and (criterion or criteria) and decod\$4	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:15
L10	41	sindhushayana-nag\$.in.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:15
L11	8	sindhushayana-nag\$.in. and (quality near2 metric\$1)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:17
L12	17	sindhushayana-nag\$.in. and (threshold)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:17
L13	30	sindhushayana-nag\$.in. and (decod\$4)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:17
L14	16	sindhushayana-nag\$.in. and (decod\$4) and threshold	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:18

L15	5	sindhushayana-nag\$.in. and (decod\$4) and threshold and (quality near2 metric\$1)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:19
L16	3	sindhushayana-nag\$.in. and (decod\$4) and criterion	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:19
L17	4	((quality adj2 metric) near10 (determ\$5 or estimat\$5)) same threshold) same parameter\$1	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L18	7	((quality adj2 metric) near10 (determ\$5 or estimat\$5)) and ((reduc\$5 or minimiz\$5 or decreas\$4) near4 power near3 decod\$4)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:23
L19	0	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 714/786.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:24
L20	0	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 714/794.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:25
L21	1	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 375/341.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:26
L22	0	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 375/262.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:26

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	22	(reducing adj2 power adj2 consumption) near10 decoder	US-PGPUB	OR	OFF	2005/09/19 15:33
L3	3	((reducing adj2 power adj2 consumption) near10 decoder) and ("quality metric")	US-PGPUB	OR	OFF	2005/09/19 15:34
L5	31	("quality metric threshold")	US-PGPUB	OR	OFF	2005/09/19 15:36
L6	3	(delimiting near5 interval)	US-PGPUB	OR	OFF	2005/09/19 15:36

DB = East

Examiner init<sup>intd.</sup> = EA


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## » Key

IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

## Select Article Information

- ☐ 1. **A framework for call admission control with threshold setup and evaluation performance in WCDMA systems**  
Badia, L.; Zorzi, M.;  
Vehicular Technology Conference, 2003. VTC 2003-Spring. The 57th IEEE Se  
Volume 2, 22-25 April 2003 Page(s):1213 - 1217 vol.2  
Digital Object Identifier 10.1109/VETECS.2003.1207820  
[AbstractPlus](#) | Full Text: [PDF](#)(461 KB) IEEE CNF
- ☐ 2. **Fluid analysis of early message discarding policy under heavy traffic**  
Dube, P.; Altman, E.;  
INFOCOM 2002. Twenty-First Annual Joint Conference of the IEEE Computer  
Communications Societies. Proceedings. IEEE  
Volume 3, 23-27 June 2002 Page(s):1307 - 1315 vol.3  
Digital Object Identifier 10.1109/INFCOM.2002.1019381  
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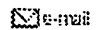
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## » Key

IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

## Select Article Information

- ☐ 1. **A single-V/sub t/ low-leakage gated-ground cache for deep submicron**  
 Agarwal, A.; Hai Li; Roy, K.;  
 Solid-State Circuits, IEEE Journal of  
 Volume 38, Issue 2, Feb. 2003 Page(s):319 - 328  
 Digital Object Identifier 10.1109/JSSC.2002.807414  
[AbstractPlus](#) | [References](#) | Full Text: [PDF](#)(1140 KB) IEEE JNL
- ☐ 2. **DRG-cache: a data retention gated-ground cache for low power**  
 Agarwal, A.; Hai Li; Roy, K.;  
 Design Automation Conference, 2002. Proceedings. 39th  
 10-14 June 2002 Page(s):473 - 478  
 Digital Object Identifier 10.1109/DAC.2002.1012671  
[AbstractPlus](#) | Full Text: [PDF](#)(727 KB) IEEE CNF
- ☐ 3. **Leakage power optimization techniques for ultra deep sub-micron multi-I**  
 Nam Sung Kim; Blaauw, D.; Mudge, T.;  
 Computer Aided Design, 2003. ICCAD-2003. International Conference on  
 9-13 Nov. 2003 Page(s):627 - 632  
[AbstractPlus](#) | Full Text: [PDF](#)(527 KB) IEEE CNF
- ☐ 4. **A low power turbo decoder architecture**  
 Elassal, M.; Bayoumi, M.;  
 Signal Processing Systems, 2003. SIPS 2003. IEEE Workshop on  
 27-29 Aug. 2003 Page(s):105 - 110  
[AbstractPlus](#) | Full Text: [PDF](#)(433 KB) IEEE CNF
- ☐ 5. **Low-power approach for decoding convolutional codes with adaptive Viti approximations**  
 Henning, R.; Chakrabarti, C.;  
 Low Power Electronics and Design, 2002. ISLPED '02. Proceedings of the 200  
 Symposium on  
 2002 Page(s):68 - 71  
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IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

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- ☐ 1. **A low power survivor memory unit for sequential Viterbi-Decoders**  
 Traber, M.;  
 Circuits and Systems, 2001. ISCAS 2001. The 2001 IEEE International Sympo  
 Volume 4, 6-9 May 2001 Page(s):214 - 217 vol. 4  
 Digital Object Identifier 10.1109/ISCAS.2001.922210  
[AbstractPlus](#) | Full Text: [PDF](#)(356 KB) IEEE CNF
- ☐ 2. **Reduced complexity blind rate detection for second and third generation systems**  
 Held, I.; Chen, A.;  
 Global Telecommunications Conference, 1999. GLOBECOM '99  
 Volume 1A, 1999 Page(s):110 - 116 vol.1a  
 Digital Object Identifier 10.1109/GLOCOM.1999.831618  
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